Se	arch	Note	S

Application/Control No.	Applicant(s)/Patent under Reexamination
10/699,306	YOON, BYEONG KI
Examiner	Art Unit
Dru M. Parries	2836

SEARCHED			
	SEARCHED		
Class	Subclass	Date	Examiner
307	116	2/11/2006	DMP
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INTERFERENCE SEARCHED			
Class	· Subclass	Date	Examiner
	L		
Interference search conducted		12/15/2006	DMP

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST search notes attached (REVISED)	12/15/2006	DMP
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